**CETECOM™****CETECOM ICT Services**
consulting - testing - certification >>>

TEST REPORT

Test report no.: 1-0210/15-01-05-C

Deutsche
Akkreditierungsstelle
D-PL-12076-01-00

Testing laboratory

CETECOM ICT Services GmbH

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Internet: <http://www.cetecom.com>e-mail: ict@cetecom.com**Accredited Testing Laboratory:**

The testing laboratory (area of testing) is accredited according to DIN EN ISO/IEC 17025 (2005) by the Deutsche Akkreditierungsstelle GmbH (DAkkS)

The accreditation is valid for the scope of testing procedures as stated in the accreditation certificate with the registration number: D-PL-12076-01-00

Applicant

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67722 Langmeil / GERMANY

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Manufacturer

Mobotix AG

Kaiserstraße

67722 Langmeil / GERMANY

Test standard/s

47 CFR Part 15

Title 47 of the Code of Federal Regulations; Chapter I; Part 15 - Radio frequency devices

RSS - Gen Issue 4

Spectrum Management and Telecommunications Radio Standards Specifications - General Requirements and Information for the Certification of Radio Apparatus

RSS - 210 Issue 8

Spectrum Management and Telecommunications Radio Standards Specification - Licence-exempt Radio Apparatus (All Frequency Bands): Category I Equipment

For further applied test standards please refer to section 3 of this test report.

Test Item

Kind of test item: Display**Model name:** MX- Display+**FCC ID:** YYRDISPB**IC:** 9357A-DISPB

Frequency: 13.56 MHz

Technology tested: RFID

Antenna: Integrated loop antenna

Power supply: 48.0 V DC by POE

Temperature range: 0°C to +40°C



This test report is electronically signed and valid without handwriting signature. For verification of the electronic signatures, the public keys can be requested at the testing laboratory.

Test report authorised:

Stefan Bös
Lab Manager
Radio Communications & EMC

Test performed:

David Lang
Lab Manager
Radio Communications & EMC

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2 General information

2.1 Notes and disclaimer

The test results of this test report relate exclusively to the test item specified in this test report. CETECOM ICT Services GmbH does not assume responsibility for any conclusions and generalizations drawn from the test results with regard to other specimens or samples of the type of the equipment represented by the test item.

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This test report replaces the test report with the number 1-0210/15-01-05-B and dated 2015-11-27

2.2 Application details

Date of receipt of order:	2015-07-31
Date of receipt of test item:	2015-08-24
Start of test:	2015-08-24
End of test:	2015-09-21
Person(s) present during the test:	-/-

3 Test standard/s

Test standard	Date	Test standard description
47 CFR Part 15	01.10.2013	Title 47 of the Code of Federal Regulations; Chapter I; Part 15 - Radio frequency devices
RSS - Gen Issue 4	November 2014	Spectrum Management and Telecommunications Radio Standards Specifications - General Requirements and Information for the Certification of Radio Apparatus
RSS - 210 Issue 8	December 2010	Spectrum Management and Telecommunications Radio Standards Specification - Licence-exempt Radio Apparatus (All Frequency Bands): Category I Equipment
RSS - 210 Issue 8 Amendment 1	February 2015	RSS-210, Amendment 1 — Licence-Exempt, Low-Power Radio Apparatus Operating in the Television Bands (February 2015)

3.1 Measurement guidance

Guidance	Version	Description
ANSI C63.4-2014	-/-	American national standard for methods of measurement of radio-noise emissions from low-voltage electrical and electronic equipment in the range of 9 kHz to 40 GHz
ANSI C63.10-2013	-/-	American national standard of procedures for compliance testing of unlicensed wireless devices

4 Test environment

Temperature:	T_{nom}	+22 °C during room temperature tests
	T_{max}	+40 °C during high temperature tests
	T_{min}	0 °C during low temperature tests
Relative humidity content:		51 %
Barometric pressure:		not relevant for this kind of testing
Power supply:	V_{nom}	48.0 V DC by POE
	V_{max}	48.0 V
	V_{min}	12.0 V

5 Test item

Kind of test item	:	Display
Type identification	:	MX- Display+
PMN	:	MXDisplay+
HVIN	:	MXDisplay+
FVIN	:	0.0.1.2
HMN	:	-/-
S/N serial number	:	10.7.1.133 and 10.7.32.84
HW hardware status	:	Mainboard: 2V3 Peripheralboard: 2V2
SW software status	:	0.0.1.2
Frequency band	:	13.56 MHz
Type of radio transmission	:	Modulated carrier
Use of frequency spectrum	:	
Type of modulation	:	AM
Antenna	:	Integrated loop antenna
Power supply	:	48.0 V DC by POE
Temperature range	:	0°C to +40°C

5.1 Additional information

The content of the following annexes is defined in the QA. It may be that not all of the listed annexes are necessary for this report, thus some values in between may be missing.

Test setup- and EUT-photos are included in test report: 1-0210/15-01-01_AnnexA
 1-0210/15-01-01_AnnexB
 1-0210/15-01-01_AnnexD

6 Test laboratories sub-contracted

None

7 Description of the test setup

Typically, the calibrations of the test apparatus are commissioned to and performed by an accredited calibration laboratory. The calibration intervals are determined in accordance with the DIN EN ISO/IEC 17025. In addition to the external calibrations, the laboratory executes comparison measurements with other calibrated test systems or effective verifications. Weekly chamber inspections and range calibrations are performed. Where possible, RF generating and signaling equipment as well as measuring receivers and analyzers are connected to an external high-precision 10 MHz reference (GPS-based or rubidium frequency standard).

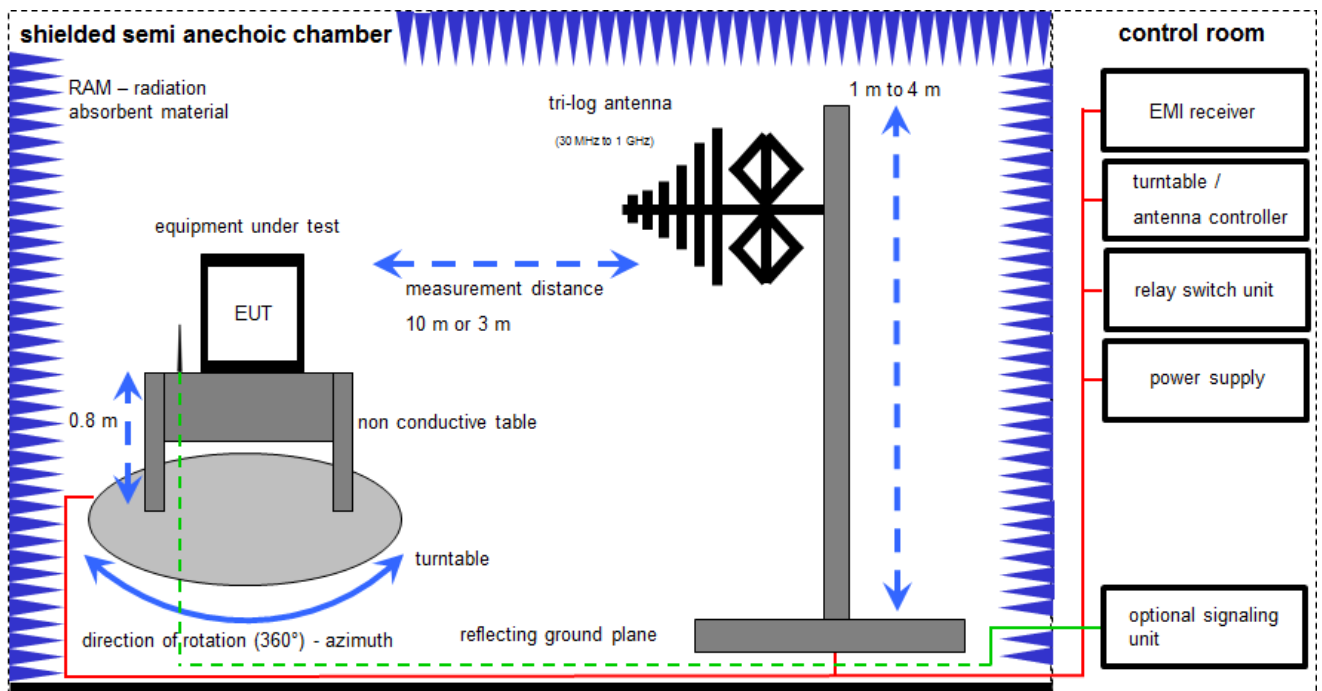
In order to simplify the identification of the equipment used at some special tests, some items of test equipment and ancillaries can be provided with an identifier or number in the equipment list below (Lab/Item).

Agenda: Kind of Calibration

k	calibration / calibrated	EK	limited calibration
ne	not required (k, ev, izw, zw not required)	zw	cyclical maintenance (external cyclical maintenance)
ev	periodic self verification	izw	internal cyclical maintenance
Ve	long-term stability recognized	g	blocked for accredited testing
vkl!	Attention: extended calibration interval		
NK!	Attention: not calibrated	*)	next calibration ordered / currently in progress

7.1 Shielded semi anechoic chamber

The radiated measurements are performed in vertical and horizontal plane in the frequency range from 9 kHz to 1 GHz in semi-anechoic chambers. The EUT is positioned on a non-conductive support with a height of 0.80 m above a conductive ground plane that covers the whole chamber. The receiving antennas are confirmed with specifications ANSI C63. These antennas can be moved over the height range between 1.0 m and 4.0 m in order to search for maximum field strength emitted from EUT. The measurement distances between EUT and receiving antennas are indicated in the test setups for the various frequency ranges. For each measurement, the EUT is rotated in all three axes until the maximum field strength is received. The wanted and unwanted emissions are received by spectrum analyzers where the detector modes and resolution bandwidths over various frequency ranges are set according to requirement ANSI C63.



$$SS = U_R + CL + AF$$

(SS-signal strength; U_R -voltage at the receiver; CL-loss of the cable; AF-antenna factor)

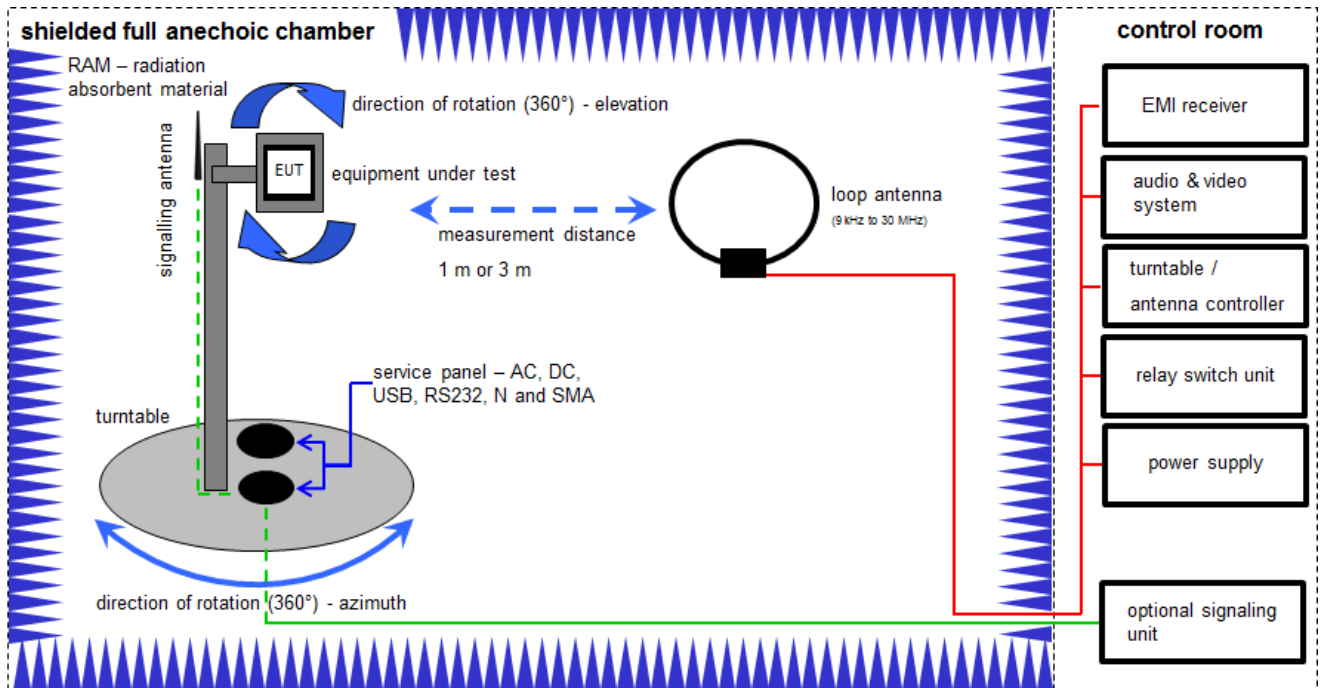
Example calculation:

$$SS \text{ [dB}\mu\text{V/m]} = 12.35 \text{ [dB}\mu\text{V/m]} + 1.90 \text{ [dB]} + 16.80 \text{ [dB}\mu\text{V/m]} = 31.05 \text{ [dB}\mu\text{V/m]} \text{ (35.69 } \mu\text{V/m)}$$

Equipment table:

No.	Lab / Item	Equipment	Type	Manuf.	Serial No.	INV. No Cetecom	Kind of Calibration	Last Calibration	Next Calibration
1	A	EMI Test Receiver	ESCI 3	R&S	100083	300003312	k	26.01.2015	26.01.2016
2	A	Antenna Tower	Model 2175	ETS-Lindgren	64762	300003745	izw	-/-	-/-
3	A	Turntable Interface-Box	Model 105637	ETS-Lindgren	44583	300003747	izw	-/-	-/-
4	A	TRILOG Broadband Test-Antenna 30 MHz - 3 GHz	VULB9163	Schwarzbeck	295	300003787	k	22.04.2014	22.04.2016

7.2 Shielded fully anechoic chamber



$$SS = U_R + CA + AF$$

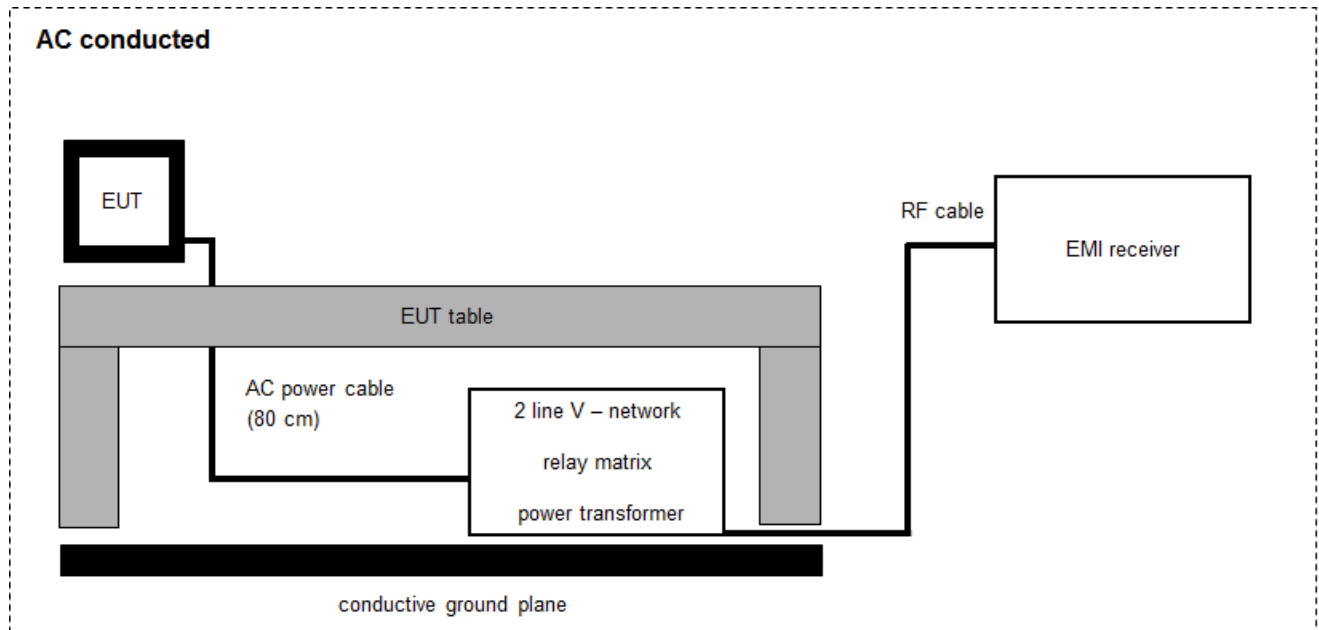
(SS-signal strength; U_R -voltage at the receiver; CA-loss of the signal path; AF-antenna factor)

Example calculation:

$$SS \text{ [dB}\mu\text{V/m]} = 40.0 \text{ [dB}\mu\text{V/m]} + (-35.8) \text{ [dB]} + 32.9 \text{ [dB}\mu\text{V/m]} = 37.1 \text{ [dB}\mu\text{V/m]} \text{ (71.61 } \mu\text{V/m)}$$

Equipment table:

No.	Lab / Item	Equipment	Type	Manufact.	Serial No.	INV. No Cetecom	Kind of Calibration	Last Calibration	Next Calibration
1	B	DC power supply, 60Vdc, 50A, 1200 W	6032A	HP	2818A03450	300001040	Ve	20.01.2015	20.01.2018
2	B	Anechoic chamber	FAC 3/5m	MWB / TDK	87400/02	300000996	ev	-/-	-/-
3	B	Switch / Control Unit	3488A	HP	*	300000199	ne	-/-	-/-
4	B	Active Loop Antenna 10 kHz to 30 MHz	6502	Kontron Psychotech	8905-2342	300000256	k	24.06.2015	24.06.2017
5	B	MXE EMI Receiver 20 Hz to 26,5 GHz	N9038A	Agilent Technologies	MY51210197	300004405	k	06.03.2015	06.03.2016
6	B	4U RF Switch Platform	L4491A	Agilent Technologies	MY50000037	300004509	ne	-/-	-/-

7.3 AC conducted

$$SS = UR + CF + VC$$

(SS-signal strength; UR-voltage at the receiver; CR-loss of the cable and filter; VC-correction factor of the ISN)

Example calculation:

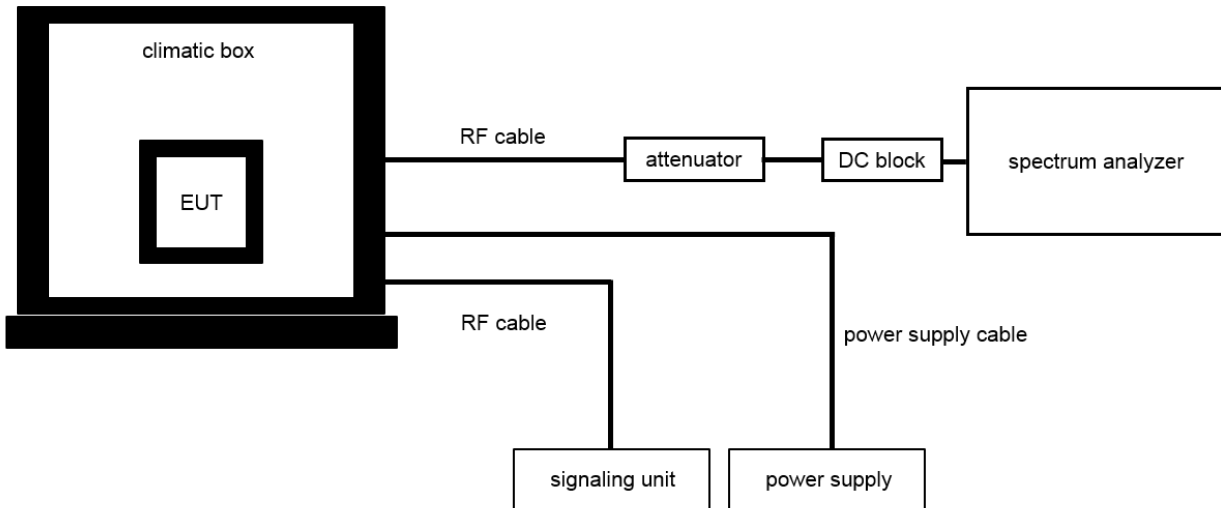
$$SS \text{ [dB}\mu\text{V/m]} = 37.62 \text{ [dB}\mu\text{V/m]} + 9.90 \text{ [dB]} + 0.23 \text{ [dB]} = 47.75 \text{ [dB}\mu\text{V/m]} \text{ (244.06 } \mu\text{V/m)}$$

Equipment table:

No.	Lab / Item	Equipment	Type	Manufact.	Serial No.	INV. No Cetecom	Kind of Calibration	Last Calibration	Next Calibration
1	C	EMI-Receiver	8542E	HP	3617A00170	300000568	k	28.01.2015	28.01.2016
2	C	Analyzer-Reference-System (Harmonics and Flicker)	ARS 16/1	SPS	A3509 07/0 0205	300003314	Ve	11.02.2014	11.02.2016
3	C	Netznachbildung	ESH3-Z5	R&S	892475/017	300002209	k	17.06.2014	17.06.2016

7.4 Conducted measurements normal and extreme conditions

Conducted measurements normal & extreme conditions



$$OP = AV + CA$$

(OP-output power; AV-analyzer value; CA-loss signal path)

Example calculation:

$$OP \text{ [dBm]} = 6.0 \text{ [dBm]} + (11.7) \text{ [dB]} = 17.7 \text{ [dBm]} (58.88 \text{ mW})$$

Equipment table:

No.	Lab / Item	Equipment	Type	Manufact.	Serial No.	INV. No Cetecom	Kind of Calibration	Last Calibration	Next Calibration
1	D	DC power supply, 60Vdc, 50A, 1200 W	6032A	HP	2818A03450	300001040	Ve	20.01.2015	20.01.2018
2	D	Temperature Test Chamber	VT 4002	Heraeus Voetsch	521/83761	300002326	Ve	26.09.2013	26.09.2015
3	D	EMI Test Receiver 9 kHz - 3 GHz incl. Preselector	ESPI3	R&S	101713	300004059	k	23.01.2015	23.01.2016
4	D	Signal Analyzer 20Hz-26,5GHz-150 to + 30 DBM	FSIQ26	R&S	835111/0004	300002678	Ve	22.01.2015	22.01.2017

8 Measurement uncertainty

Measurement uncertainty	
Test case	Uncertainty
Antenna gain	± 3 dB
Spectrum bandwidth	± 21.5 kHz absolute; ± 15.0 kHz relative
Maximum output power	± 1 dB
Detailed conducted spurious emissions @ the band edge	± 1 dB
Band edge compliance radiated	± 3 dB
Spurious emissions conducted	± 3 dB
Spurious emissions radiated below 30 MHz	± 3 dB
Spurious emissions radiated 30 MHz to 1 GHz	± 3 dB
Spurious emissions radiated 1 GHz to 12.75 GHz	± 3.7 dB
Spurious emissions radiated above 12.75 GHz	± 4.5 dB
Spurious emissions conducted below 30 MHz (AC conducted)	± 2.6 dB

9 Sequence of testing

9.1 Sequence of testing 9 kHz to 30 MHz

Setup

- The equipment was set up to simulate a typical usage like described in the user manual or described by manufacturer.
- If the EUT is a tabletop system, a rotatable table with 1.5 m height is used.
- If the EUT is a floor standing device, it is placed on the ground.
- Auxiliary equipment and cables were positioned to simulate normal operation conditions as described in ANSI C 63.4.
- The AC power port of the EUT (if available) is connected to a power outlet below the turntable.
- The measurement distance is 3 meter (see ANSI C 63.4) – see each test details
- The EUT was set into operation.

Premeasurement

- The turntable rotates from 0° to 315° using 45° steps.
- The antenna height is 1.5 meter.
- At each turntable position the analyzer sweeps with peak detection to find the maximum of all emissions

Final measurement

- Identified emissions during the premeasurement the software maximizes by rotating the turntable position (0° to 360°) and by rotating the elevation axes (0° to 360°).
- The final measurement will be done in the position (turntable and elevation) causing the highest emissions with QPK (QPK / see ANSI C 63.4) detector
- The final levels, frequency, measuring time, bandwidth, turntable position, correction factor, margin to the limit and limit will be recorded. Also a plot with the graph of the premeasurement and the limit will be stored.

9.2 Sequence of testing 30 MHz to 1 GHz

Setup

- The equipment was set up to simulate a typical usage like described in the user manual or described by manufacturer.
- If the EUT is a tabletop system, a table with 0.8 m height is used, which is placed on the ground plane.
- If the EUT is a floor standing device, it is placed on the ground plane with insulation between both.
- Auxiliary equipment and cables were positioned to simulate normal operation conditions as described in ANSI C 63.4.
- The AC power port of the EUT (if available) is connected to a power outlet below the turntable.
- The measurement distance is 10 or 3 meter (see ANSI C 63.4) – see each test details
- The EUT was set into operation.
-

Premeasurement

- The turntable rotates from 0° to 315° using 45° steps.
- The antenna is polarized vertical and horizontal.
- The antenna height changes from 1 to 3 meter.
- At each turntable position, antenna polarization and height the analyzer sweeps three times in peak to find the maximum of all emissions
-

Final measurement

- The final measurement will be performed with minimum the six highest peaks.
- According to the maximum antenna and turntable positions of premeasurement the software maximize the peaks by changing turntable position ($\pm 45^\circ$) and antenna movement between 1 and 4 meter.
- The final measurement will be done with QP (Quasi-Peak / see ANSI C 63.4) detector with an EMI receiver

The final levels, frequency, measuring time, bandwidth, antenna height, antenna polarization, turntable angle, correction factor, margin to the limit and limit will be recorded. Also a plot with the graph of the premeasurement with marked maximum final

10 Summary of measurement results

<input checked="" type="checkbox"/>	No deviations from the technical specifications were ascertained
<input type="checkbox"/>	There were deviations from the technical specifications ascertained
<input type="checkbox"/>	This test report is only a partial test report. The content and verdict of the performed test cases are listed below.

TC Identifier	Description	Verdict	Date	Remark
RF-Testing	CFR Part 15 RSS 210 Issue 8 RSS Gen Issue 4	See table!	2016-02-26	-/-

Test specification clause	Test case	Temperature conditions	Power source conditions	C	NC	NA	NP	Remark
RSS Gen Issue 4	Occupied bandwidth	Nominal	Nominal	<input checked="" type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	-/-
§ 15.225 (a)	Field strength of the fundamental	Nominal	Nominal	<input checked="" type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	-/-
§ 15.209 & § 15.225 (b-d)	Field strength of the harmonics and spurious	Nominal	Nominal	<input checked="" type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	-/-
§ 15.109	Receiver spurious emissions and cabinet radiations	Nominal	Nominal	<input type="checkbox"/>	<input type="checkbox"/>	<input checked="" type="checkbox"/>	<input type="checkbox"/>	-/-
§15.107 §15.207	Conducted limits	Nominal	Nominal	<input checked="" type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	-/-
§ 15.225 (a)	Frequency tolerance	Normal & extreme conditions	Normal & extreme conditions	<input checked="" type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	-/-

Note: C = Complies; NC = Not complies; NA = Not applicable; NP = Not performed

11 Additional comments

Reference documents: None

Special test descriptions: None

Configuration descriptions: None

12 Measurement results

12.1 Occupied bandwidth

Measurement:

The emission bandwidth (x dB) is defined as the frequency range between two points, one above and one below the carrier frequency, at which the spectral density of the emission is attenuated x dB below the maximum in-band spectral density of the modulated signal.

Measurement parameters	
Detector:	Peak
Resolution bandwidth:	1 % – 5 % of the occupied bandwidth
Video bandwidth:	≥ 3x RBW
Trace mode:	Max hold
Analyser function:	99 % power function
Used equipment:	See chapter 7.4
Measurement uncertainty:	See chapter 8

Limit:

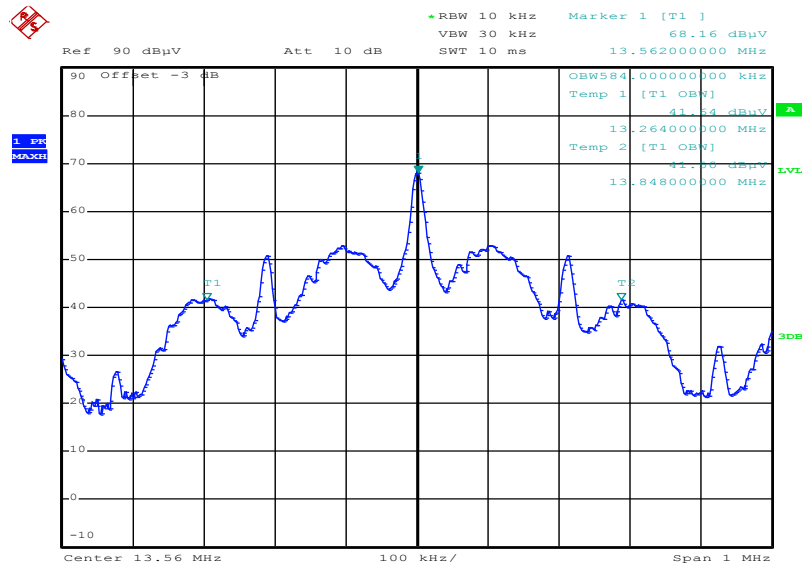
IC
for RSP-100 test report coversheet only

Result EUT A:

99% emission bandwidth
584 kHz

Plot:

Plot 1: 99 % emission bandwidth



Date: 26.AUG.2015 11:02:11

12.2 Field strength of the fundamental

Measurement:

The maximum detected field strength for the carrier signal.

Measurement parameters	
Detector:	Quasi peak / peak (worst case)
Resolution bandwidth:	120 kHz
Video bandwidth:	$\geq 3 \times \text{RBW}$
Trace mode:	Max hold
Used equipment:	See chapter 7.2
Measurement uncertainty:	See chapter 8

Limit:

FCC & IC		
Frequency (MHz)	Field strength ($\mu\text{V/m}$)	Measurement distance (m)
13.553 to 13.567	15,848 (84 dB $\mu\text{V/m}$)	30

Recalculation:

According to ANSI C63.10		
Frequency	Formula	Correction value
13.56 MHz	$\text{FS}_{\text{limit}} = \text{FS}_{\text{max}} - 40 \log\left(\frac{d_{\text{nearfield}}}{d_{\text{measure}}}\right) - 20 \log\left(\frac{d_{\text{limit}}}{d_{\text{nearfield}}}\right)$	-21.39

According to ANSI C63.10

Result:

Field strength of the fundamental		
Frequency	13.56 MHz	
Distance	@ 3 m	@ 30 m
Measured / calculated value	77.3 dB $\mu\text{V/m}$	55.9 dB $\mu\text{V/m}$

12.3 Field strength of the harmonics and spurious

Measurement:

The maximum detected field strength for the harmonics and spurious.

Measurement parameters	
Detector:	Quasi peak / average or peak (worst case – pre-scan)
Resolution bandwidth:	F < 150 kHz: 200 Hz 150 kHz < F < 30 MHz: 9 kHz 30 MHz < F < 1 GHz: 120 kHz
Video bandwidth:	F < 150 kHz: 1 kHz 150 kHz < F < 30 MHz: 100 kHz 30 MHz < F < 1 GHz: 300 kHz
Trace mode:	Max hold
Used equipment:	See chapter 7.1 and 7.2
Measurement uncertainty:	See chapter 8

Limit:

FCC & IC		
Frequency (MHz)	Field strength (dB μ V/m)	Measurement distance (m)
0.009 – 0.490	2400/F(kHz)	300
0.490 – 1.705	24000/F(kHz)	30
1.705 – 30	30 (29.5 dB μ V/m)	30
30 – 88	100 (40 dB μ V/m)	3
88 – 216	150 (43.5 dB μ V/m)	3
216 – 960	200 (46 dB μ V/m)	3

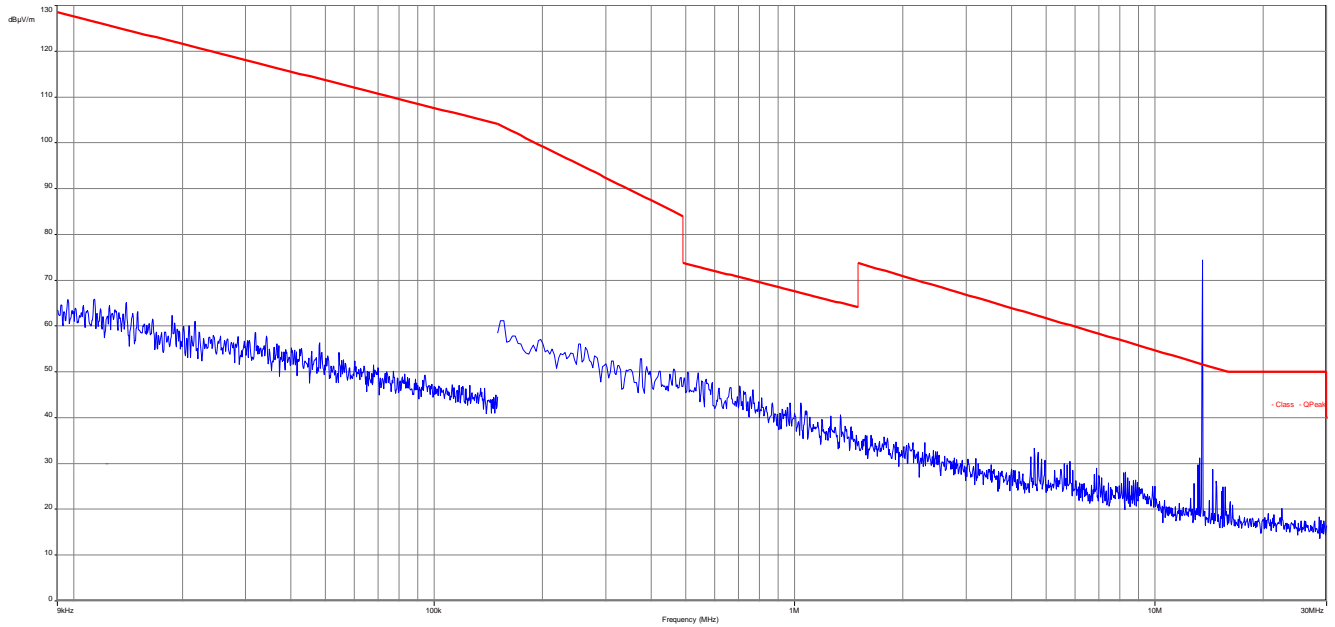
Note: For a reduced measurement distance, please take a look at the limit line and the ANSI C63.10-2013 sub clause 6.4 radiated emissions from unlicensed wireless devices below 30 MHz.

Result:

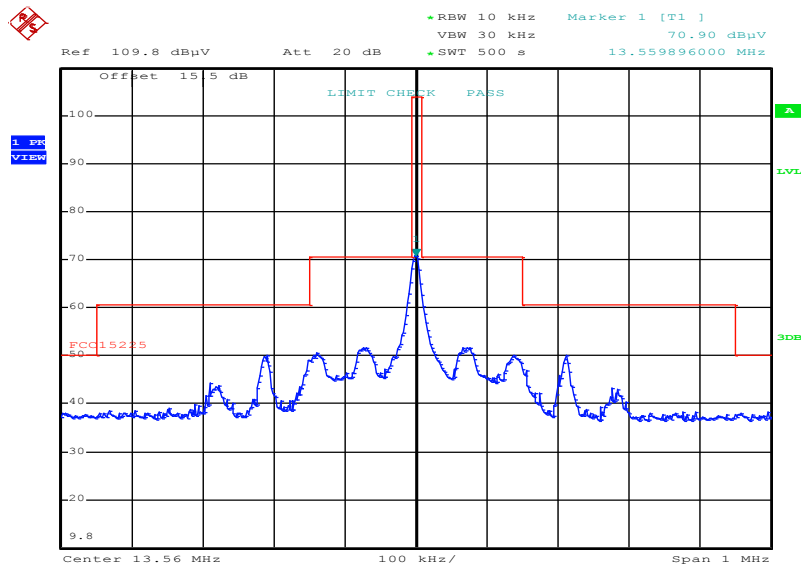
Detected emissions			
Frequency (MHz)	Detector	Resolution bandwidth (kHz)	Detected value
All peaks detected in range from 9 kHz to 30 MHz are > 20 dB below limit.			
For frequencies > 30 MHz see result table below the plots			

Plots:

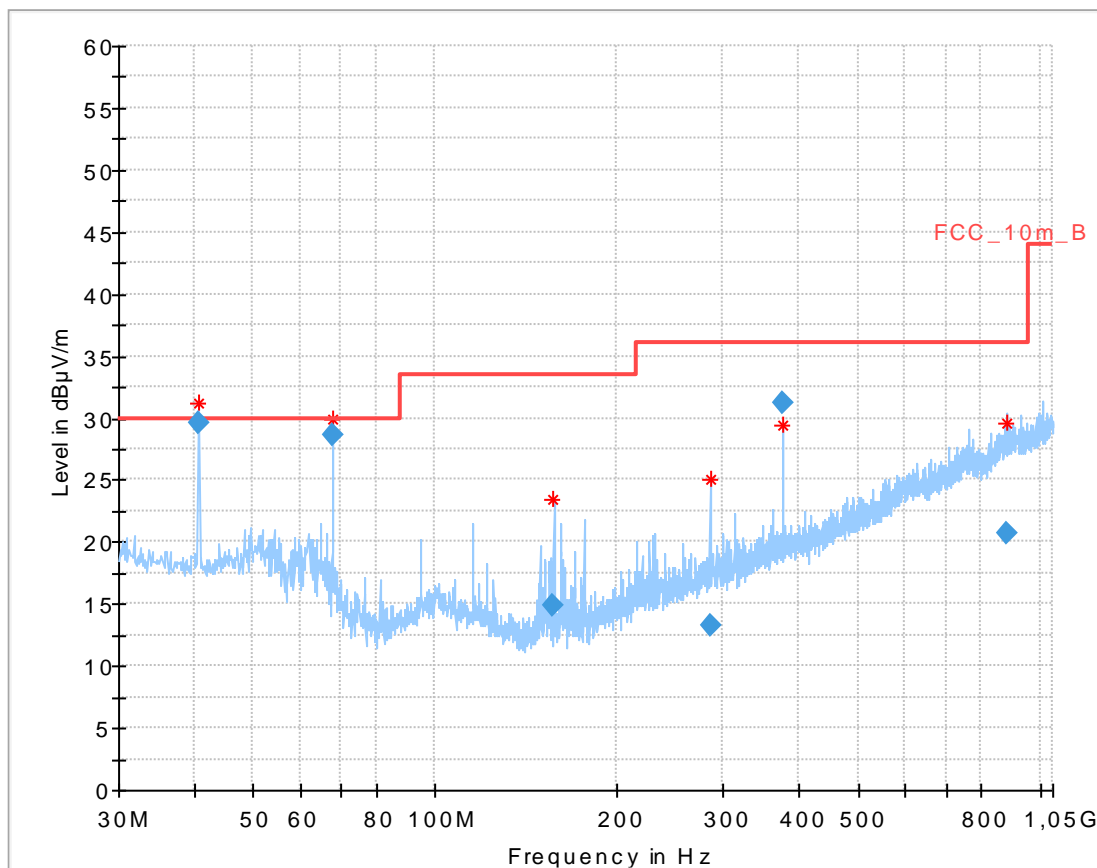
Plot 1: 9 kHz – 30 MHz, magnetic emissions



Plot 2: Spectrum mask (the limits are recalculated according to the ANSI C63.10-2013 sub clause 6.4)



Date: 18.SEP.2015 15:32:22

Plot 3: 30 MHz – 1 GHz, vertical and horizontal polarisation

Frequency (MHz)	QuasiPeak (dBµV/m)	Limit (dBµV/m)	Margin (dB)	Meas. Time (ms)	Bandwidth (kHz)	Height (cm)	Pol	Azimuth (deg)	Corr. (dB)
40.684800	29.56	30.00	0.44	1000.0	120.000	100.0	V	276	14.0
67.795200	28.69	30.00	1.31	1000.0	120.000	352.0	V	117	8.9
156.992400	14.93	33.50	18.57	1000.0	120.000	100.0	V	266	9.0
284.740350	13.31	36.00	22.69	1000.0	120.000	400.0	H	220	14.1
374.978550	31.26	36.00	4.74	1000.0	120.000	272.0	H	97	16.5
881.049000	20.74	36.00	15.26	1000.0	120.000	200.0	H	27	23.9

12.4 Conducted limits

Measurement:

Measurement of the conducted spurious emissions for an intentional radiator that is designed to be connected to the public utility (AC) power line.

Measurement parameters	
Detector:	Quasi peak / average or peak (worst case – pre-scan)
Resolution bandwidth:	F < 150 kHz: 200 Hz F > 150 kHz: 9 kHz
Video bandwidth:	F < 150 kHz: 1 kHz F > 150 kHz: 100 kHz
Trace mode:	Max hold
Used equipment:	See chapter 7.3
Measurement uncertainty:	See chapter 8

Limit:

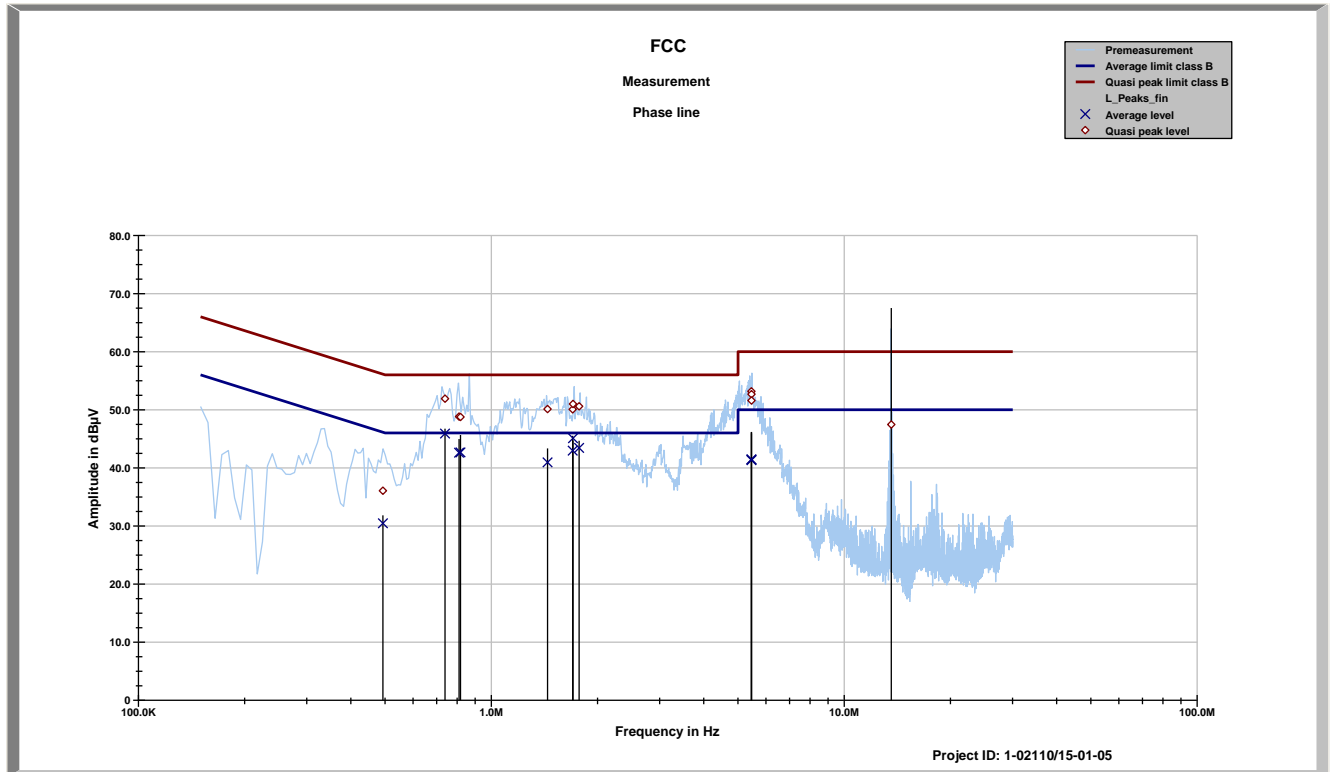
FCC & IC		
Frequency (MHz)	Quasi-peak (dB μ V/m)	Average (dB μ V/m)
0.15 – 0.5	66 to 56*	56 to 46*
0.5 – 5	56	46
5 – 30.0	60	50

Result:

Detected emissions			
Frequency (MHz)	Detector	Resolution bandwidth (kHz)	Detected value
See table below plots!			

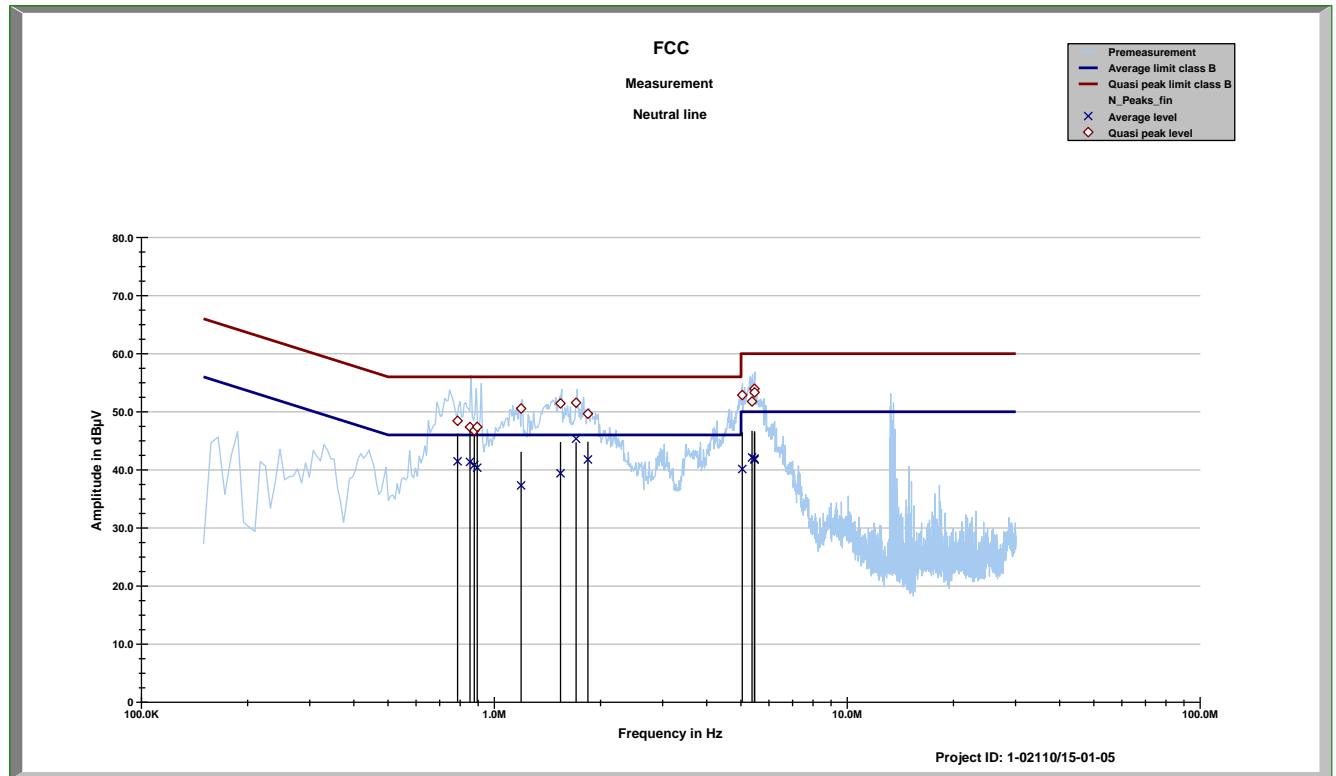
Plots:

Plot 1: 150 kHz to 30 MHz, phase line



Frequency	Quasi peak level	Margin quasi peak	Average level	Margin average
MHz	dBμV	dBμV	dBμV	dBμV
0.49302	36.06	20.06	30.46	15.74
0.73902	51.91	4.09	45.91	0.09
0.80983	48.82	7.18	42.61	3.39
0.81773	48.76	7.24	42.67	3.33
1.4426	50.11	5.89	40.94	5.06
1.6994	50.07	5.93	42.95	3.05
1.7033	51.00	5.00	45.09	0.91
1.7725	50.60	5.40	43.44	2.56
5.4554	53.17	6.83	41.45	8.55
5.4566	52.67	7.33	41.43	8.57
5.4569	51.58	8.42	41.32	8.68
13.583	47.46	12.54	47.41	2.59

Plot 2: 150 kHz to 30 MHz, neutral line



Frequency	Quasi peak level	Margin quasi peak	Average level	Margin average
MHz	dBμV	dBμV	dBμV	dBμV
0.78695	48.44	7.56	41.47	4.53
0.85333	47.37	8.63	41.36	4.64
0.87698	46.76	9.24	40.83	5.17
0.89434	47.39	8.61	40.38	5.62
1.191	50.55	5.45	37.32	8.68
1.5402	51.43	4.57	39.40	6.60
1.7044	51.56	4.44	45.36	0.64
1.8414	49.64	6.36	41.78	4.22
5.0407	52.87	7.13	40.14	9.86
5.3725	51.77	8.23	42.14	7.86
5.4588	53.96	6.04	41.94	8.06
5.4598	53.33	6.67	41.76	8.24

12.5 Frequency error

Measurement:

The maximum detected field strength for the spurious.

Measurement parameters	
Detector:	Peak detector
Resolution bandwidth:	10 Hz / 100 Hz
Video bandwidth:	> RBW
Trace mode:	Max hold
Used equipment:	See chapter 7.4
Measurement uncertainty:	See chapter 8

Limit:

FCC
The frequency tolerance of the carrier signal shall be maintained within +/- 0.01% of the operating frequency over a temperature variation of -20 degrees to +50 degrees C at normal supply voltage, and for a variation in the primary supply voltage from 85% to 115% of the rated supply voltage at a temperature of 20 degrees C. (± 1.356 kHz)

Results: Temperature variation

Frequency tolerance		
Measured frequency (MHz)	Conditions	Result
13.559896	-20 °C & 100% voltage	complies
13.559908	-10 °C & 100% voltage	complies
13.559888	0 °C & 100% voltage	complies
13.559876	+10 °C & 100% voltage	complies
13.559872	+20 °C & 100% voltage	complies
13.559776	+30 °C & 100% voltage	complies
13.559776	+40 °C & 100% voltage	complies
13.559768	+50 °C & 100% voltage	complies

Results: Voltage variation

Frequency tolerance		
Measured frequency (MHz)	Temperature	Result
13.559872	+20 °C & 85% voltage	complies
13.559872	+20 °C & 100% voltage	complies
13.559872	+20 °C & 115% voltage	complies
Measurement uncertainty		\pm RBW

13 Observations

No observations except those reported with the single test cases have been made.

Annex A Document history

Version	Applied changes	Date of release
	Initial release	2015-09-29
-A	Editorial changes (FCC/IC ID, HVIN,FVIN)	2015-11-24
-B	Editorial changes (HVIN,HMN)	2015-11-27
-C	Editorial changes (Section 5)	2016-02-26

Annex B Further information

Glossary

AVG	-	Average
DUT	-	Device under test
EMC	-	Electromagnetic Compatibility
EN	-	European Standard
EUT	-	Equipment under test
ETSI	-	European Telecommunications Standard Institute
FCC	-	Federal Communication Commission
FCC ID	-	Company Identifier at FCC
HW	-	Hardware
IC	-	Industry Canada
Inv. No.	-	Inventory number
N/A	-	Not applicable
PP	-	Positive peak
QP	-	Quasi peak
S/N	-	Serial number
SW	-	Software
PMN		Product marketing name
HMN		Host marketing name
HVIN		Hardware version identification number
FVIN		Firmware version identification number

Annex C Accreditation Certificate

Front side of certificate

Back side of certificate



Deutsche Akkreditierungsstelle GmbH

Befehlens gemäß § 8 Absatz 1 AkkStelleG i.V.m. § 1 Absatz 1 AkkStelleG i.V.m.
Unterzeichnerin der Multilateralen Abkommen
von EA, ILAC und IAF zur gegenseitigen Anerkennung

Akkreditierung



Die Deutsche Akkreditierungsstelle GmbH bestätigt hiermit, dass das Prüflaboratorium

CETECOM ICT Services GmbH
Untertürkheimer Straße 6-10, 66117 Saarbrücken

die Kompetenz nach DIN EN ISO/IEC 17025:2005 besitzt, Prüfungen in folgenden Bereichen durchzuführen:

Drahtgebundene Kommunikation einschließlich xDSL
VoIP und DECT
Akustik
Funk einschließlich WLAN
Short Range Devices (SRD)
RFID
WiMax und Richtfunk
Mobilfunk (GSM / DCS, Over the Air (OTA) Performance)
Elektromagnetische Verträglichkeit (EMV) einschließlich Automotive
Produktsicherheit
SAR und Hearing Aid Compatibility (HAC)
Umweltsimulation
Smart Card Terminals
Bluetooth
Wi-Fi Services

Die Akkreditierungsurkunde gilt nur in Verbindung mit dem Bescheid vom 07.03.2014 mit der
Akkreditierungsurkunde D-PL-12076-01 und ist gültig 17.03.2018. Sie besteht aus diesem Deckblatt, der
Rückseite des Deckblatts und der folgenden Anlage mit insgesamt 77 Seiten.

Registrierungsnummer der Urkunde: D-PL-12076-01-00

Frankfurt am Main, 07.03.2014

Zehn Stunden auf der Rückseite

Im Auftrag D-PL-12076-01-00
Hilfsgüter

Deutsche Akkreditierungsstelle GmbH

Standort Berlin
Spittelmarkt 10
10117 Berlin

Standort Frankfurt am Main
Gartenstraße 6
60594 Frankfurt am Main

Standort Braunschweig
Bundesallee 100
38115 Braunschweig

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die über den durch die DAkkS bestätigten Akkreditierungsbereich hinausgehen.

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31. Juli 2005 (BGBl. I S. 2625) sowie der Verordnung (EG) Nr. 765/2008 des Europäischen Parlaments
und des Rates vom 9. Juli 2008 über die Vorschriften für die Akkreditierung und Marktüberwachung
im Zusammenhang mit der Vermarktung von Produkten (Abt. L 218 vom 9. Juli 2008, S. 30).
Die DAkkS ist Unterzeichnerin der Multilateralen Abkommen zur gegenseitigen Anerkennung der
Europäische Organisation für Akkreditation (EA), des International Accreditation Forum (IAF) und
der International Laboratory Accreditation Cooperation (ILAC). Die Unterzeichner dieser Abkommen
erkennen ihre Akkreditierungen gegenseitig an.

Der aktuelle Stand der Mitgliedschaft kann folgenden Webseiten entnommen werden:
EA: www.european-accreditation.org
ILAC: www.ilac.org
IAF: www.iaf.eu

Note:

The current certificate including annex is published on our website (see link below) or may be received from CETECOM ICT Services on request.

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